



Juan De Dios Castro Receives Phi Kappa Phi Fellowship

Juan De Dios Castro, a doctoral candidate in the Department of Electrical Engineering and the Center for Wireless and Microwave Information Systems (WAMI), is a recipient of a 2017 Dissertation Fellowship from The Honor Society of Phi Kappa Phi. The fellowship supports students in the dissertation writing stage of doctoral study. Awards are for up to 12 months of dissertation writing.

The Honor Society of Phi Kappa Phi was established in 1897 to recognize and encourage superior scholarship without restriction as to area of study and to promote the "unity and democracy of education". Membership is by invitation only, by an established campus chapter, and is restricted to students with integrity and high ethical standards and who are ranked scholastically in the top of their class, regardless of field of study: the top 7.5 percent of second-semester university juniors and the top 10 percent of seniors and graduate students.

Juan is studying novel microwave materials for additive manufacturing of RF and Microwave components. His other awards include a Best Paper Award in the Applied Physics / Electrical and Computer Engineering session during the 2016 Society of Hispanic Professional Engineers (SHPE) Engineering Science Symposium, Best Graduate Student Research Poster during the 2016 HENAAC Conference, and Outstanding Student Paper" during the 2015 International Symposium on Microelectronics (IMAPS 2015). Juan is advised by Jing Wang, associate professor in the Department of Electrical Engineering, and Thomas Weller, professor and chair in the department of Electrical Engineering.

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